

SIPMOS® Small-Signal-Transistor

Features

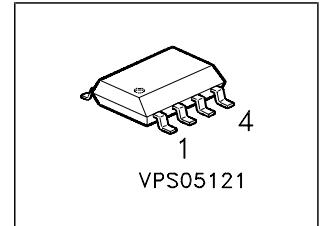
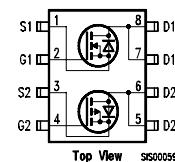
- Dual N- and P -Channel
- Enhancement mode
- Avalanche rated
- Pb-free lead plating;RoHS compliant



Product Summary

	N	P	
Drain source voltage	V_{DS}	60	-60
Drain-Source on-state resistance	$R_{DS(on)}$	0.12	0.3
Continuous drain current	I_D	3	-2
	A		

Type	Package	Marking
BSO 612 CV	PG-DSO-8	612CV



Maximum Ratings, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Value		Unit	
		N	P		
Continuous drain current $T_A = 25^\circ\text{C}$	I_D	3	-2	A	
$T_A = 70^\circ\text{C}$		2.4	-1.6		
Pulsed drain current $T_A = 25^\circ\text{C}$		12	-8		
Avalanche energy, single pulse $I_D = 3 \text{ A}, V_{DD} = 25 \text{ V}, R_{GS} = 25 \Omega$ $I_D = -2 \text{ A}, V_{DD} = -25 \text{ V}, R_{GS} = 25 \Omega$		47	-		
Avalanche energy, periodic limited by T_{jmax}	E_{AR}	0.2	0.2	mJ	
Reverse diode dv/dt, $T_{jmax} = 150^\circ\text{C}$ $I_S = 3 \text{ A}, V_{DS} = 48 \text{ V}, dI/dt = 200 \text{ A}/\mu\text{s}$ $I_S = -2 \text{ A}, V_{DS} = -48 \text{ V}, dI/dt = -200 \text{ A}/\mu\text{s}$					
Gate source voltage					
Power dissipation $T_A = 25^\circ\text{C}$	P_{tot}	2	2	W	
Operating and storage temperature					
IEC climatic category; DIN IEC 68-1		-55...+150		°C	
		55/150/56			

Termal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Dynamic Characteristics

Thermal resistance, junction - soldering point (Pin 4)	N P	R_{thJS}	- -	- -	40 40	K/W
SMD version, device on PCB: @ min. footprint; $t \leq 10$ sec.	N	R_{thJA}	-	-	110	
@ 6 cm ² cooling area ¹⁾ ; $t \leq 10$ sec.	N		-	-	62.5	
@ min. footprint; $t \leq 10$ sec.	P		-	-	70	
@ 6 cm ² cooling area ¹⁾ ; $t \leq 10$ sec.	P		-	-	62.5	

Static Characteristics, at $T_j = 25$ °C, unless otherwise specified

Drain- source breakdown voltage $V_{GS} = 0$ V, $I_D = 250$ µA $V_{GS} = 0$ V, $I_D = -250$ µA	N P	$V_{(BR)DSS}$	60 -60	- -	- -	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 20$ µA $I_D = -450$ µA	N P	$V_{GS(th)}$	2.1 -2.1	3 -3	4 -4	
Zero gate voltage drain current $V_{DS} = 60$ V, $V_{GS} = 0$ V, $T_j = 25$ °C $V_{DS} = 60$ V, $V_{GS} = 0$ V, $T_j = 125$ °C $V_{DS} = -60$ V, $V_{GS} = 0$ V, $T_j = 25$ °C $V_{DS} = -60$ V, $V_{GS} = 0$ V, $T_j = 125$ °C	N N P P	I_{DSS}	- - - -	0.1 10 -0.1 -10	1 100 -1 -100	µA
Gate-source leakage current $V_{GS} = 20$ V, $V_{DS} = 0$ V $V_{GS} = -20$ V, $V_{DS} = 0$ V	N P	I_{GSS}	- -	10 -10	100 -100	nA
Drain-source on-state resistance $V_{GS} = 10$ V, $I_D = 3$ A $V_{GS} = -10$ V, $I_D = -2$ A	N P	$R_{DS(on)}$	- -	0.09 0.22	0.12 0.3	Ω

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Transconductance $V_{DS} \geq 2 * I_D * R_{DS(on)max}, I_D = 3 \text{ A}$ $V_{DS} \geq 2 * I_D * R_{DS(on)max}, I_D = -2 \text{ A}$	g_{fs} N P	2 1.2	4 2.4	- -	S
Input capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ $V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$	C_{iss} N P	-	275 320	340 400	pF
Output capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ $V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$	C_{oss} N P	-	90 105	115 130	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ $V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$	C_{rss} N P	-	50 40	65 50	
Turn-on delay time $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_G = 33 \Omega$ $V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -2 \text{ A}, R_G = 27 \Omega$	$t_{d(on)}$ N P	-	12 15	18 23	ns
Rise time $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_G = 33 \Omega$ $V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -2 \text{ A}, R_G = 27 \Omega$	t_r N P	-	35 60	55 90	
Turn-off delay time $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_G = 33 \Omega$ $V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -2 \text{ A}, R_G = 27 \Omega$	$t_{d(off)}$ N P	-	25 145	40 220	
Fall time $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_G = 33 \Omega$ $V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -2 \text{ A}, R_G = 27 \Omega$	t_f N P	-	30 95	45 140	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

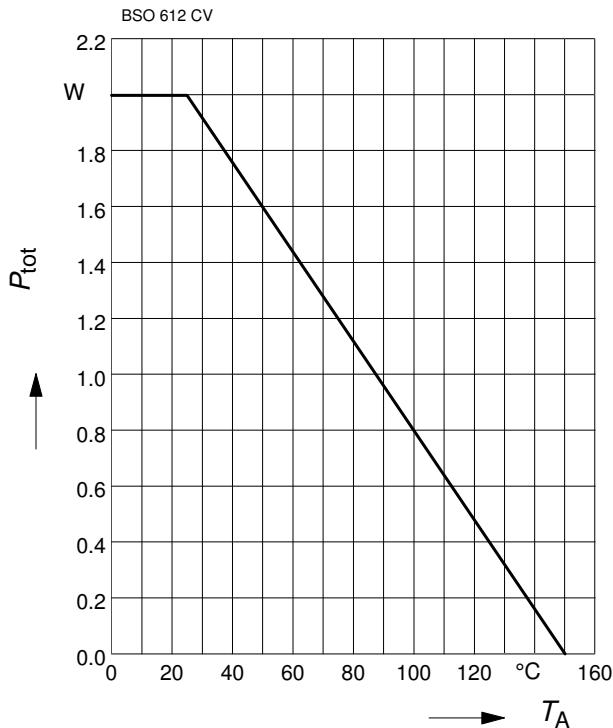
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Gate to source charge $V_{DD} = 48 \text{ V}, I_D = 3 \text{ A}$ $V_{DD} = -48 \text{ V}, I_D = -2 \text{ A}$	N	Q_{gs}	-	1	1.5
	P		-	2	3
Gate to drain charge $V_{DD} = 48 \text{ V}, I_D = 3 \text{ A}$ $V_{DD} = -48 \text{ V}, I_D = -2 \text{ A}$	N	Q_{gd}	-	5.5	8.3
	P		-	4.5	6.8
Gate charge total $V_{DD} = 48 \text{ V}, I_D = 3 \text{ A}, V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DD} = -48 \text{ V}, I_D = -2 \text{ A}, V_{GS} = 0 \text{ to } -10\text{V}$	N	Q_g	-	10.3	15.5
	P		-	10.5	16
Gate plateau voltage $V_{DD} = 48 \text{ V}, I_D = 3 \text{ A}$ $V_{DD} = -48 \text{ V}, I_D = -2 \text{ A}$	N	$V_{(\text{plateau})}$	-	5	-
	P		-	-4	-

Reverse Diode

Inverse diode continuous forward current $T_A = 25^\circ\text{C}$	N P	I_S	-	-	3 -2	A
Inverse diode direct current,pulsed $T_A = 25^\circ\text{C}$	N P	I_{SM}	-	-	12 -8	
Inverse diode forward voltage $V_{GS} = 0 \text{ V}, I_F = I_S$ $V_{GS} = 0 \text{ V}, I_F = I_S$	N P	V_{SD}	-	0.9 -0.9	1.2 -1.2	V
Reverse recovery time $V_R = 30 \text{ V}, I_F = I_S, di_F/dt = 100 \text{ A}/\mu\text{s}$ $V_R = -30 \text{ V}, I_F = I_S, di_F/dt = -100 \text{ A}/\mu\text{s}$	N P	t_{rr}	-	55 55	85 85	ns
Reverse recovery charge $V_R = 30 \text{ V}, I_F = I_S, di_F/dt = 100 \text{ A}/\mu\text{s}$ $V_R = -30 \text{ V}, I_F = I_S, di_F/dt = -100 \text{ A}/\mu\text{s}$	N P	Q_{rr}	-	90 65	135 100	nC

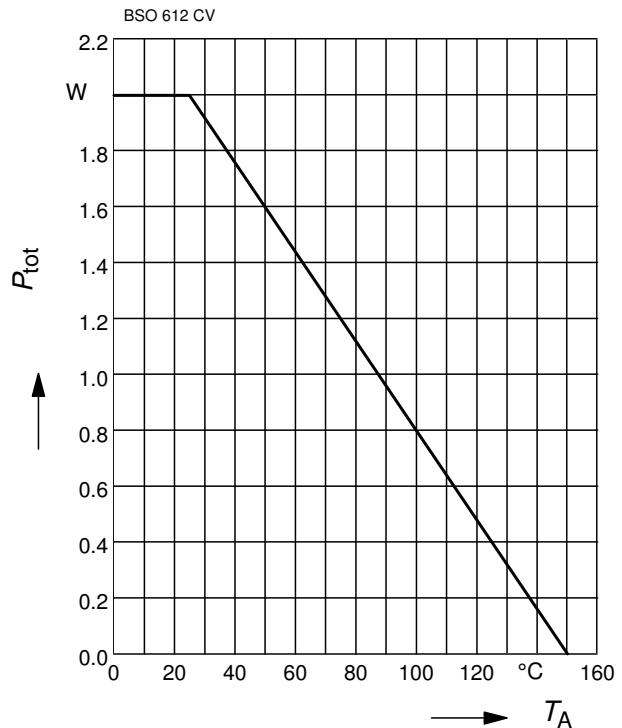
Power Dissipation (N-Ch.)

$$P_{\text{tot}} = f(T_A)$$



Power Dissipation (P-Ch.)

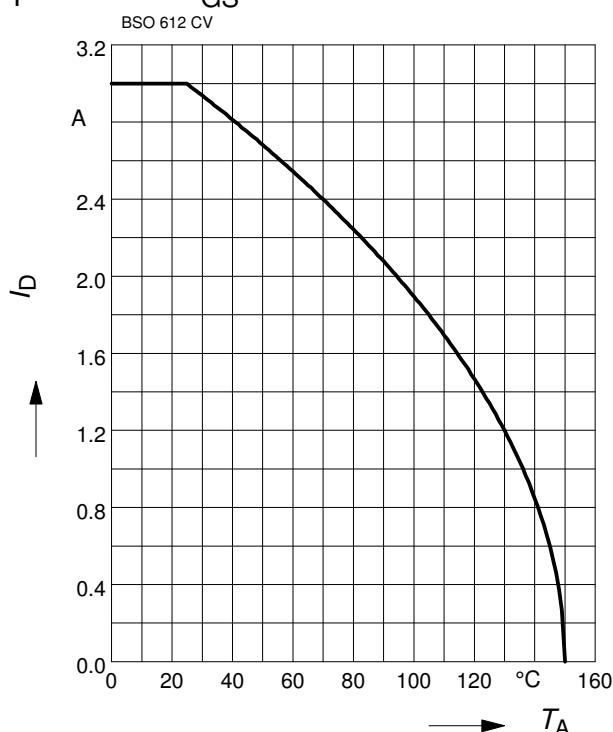
$$P_{\text{tot}} = f(T_A)$$



Drain current (N-Ch.)

$$I_D = f(T_A)$$

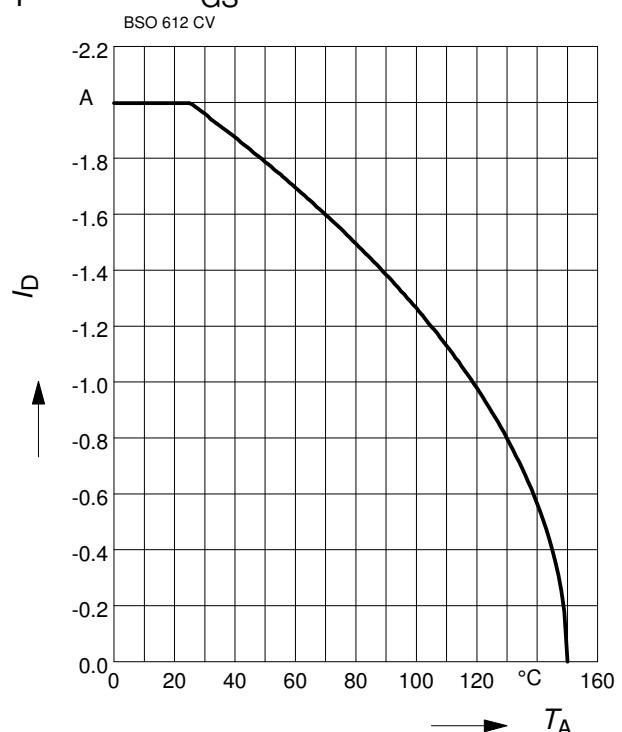
parameter: $V_{GS} \geq 10$ V



Drain current (P-Ch.)

$$I_D = f(T_A)$$

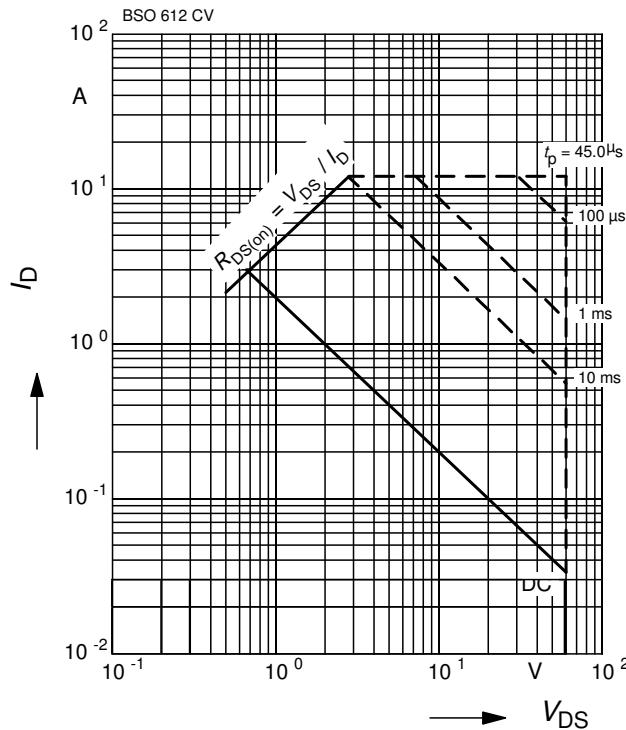
parameter: $V_{GS} \geq -10$ V



Safe operating area (N-Ch.)

$$I_D = f(V_{DS})$$

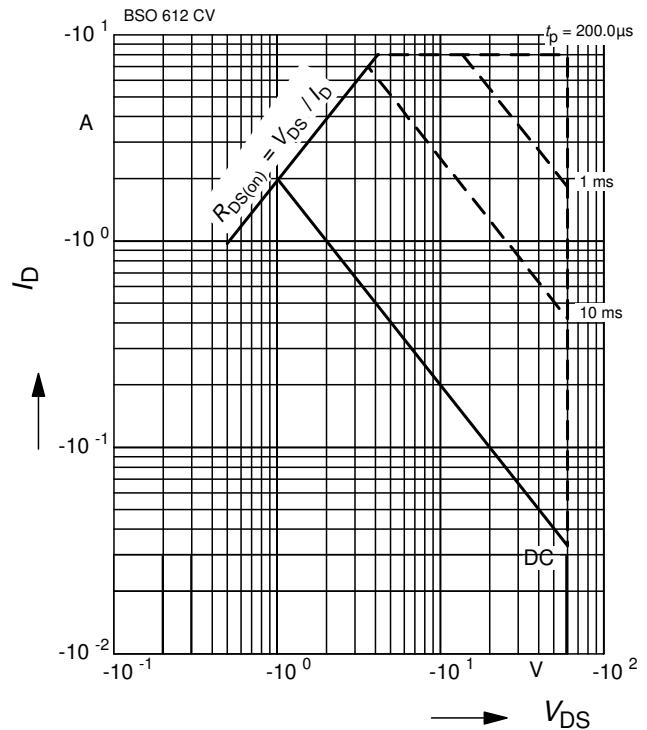
parameter : $D = 0$, $T_A = 25^\circ\text{C}$



Safe operating area (P-Ch.)

$$I_D = f(V_{DS})$$

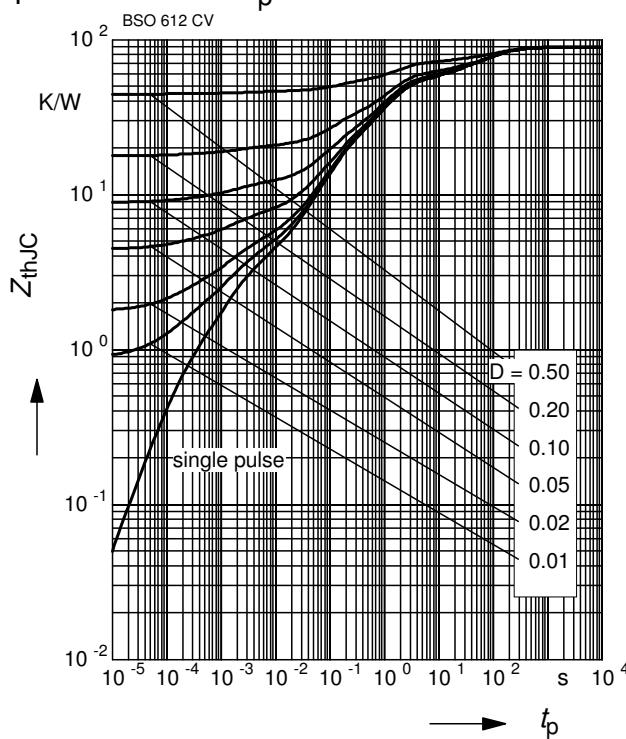
parameter : $D = 0$, $T_A = 25^\circ\text{C}$



Transient thermal impedance (N-Ch.)

$$Z_{\text{thJC}} = f(t_p)$$

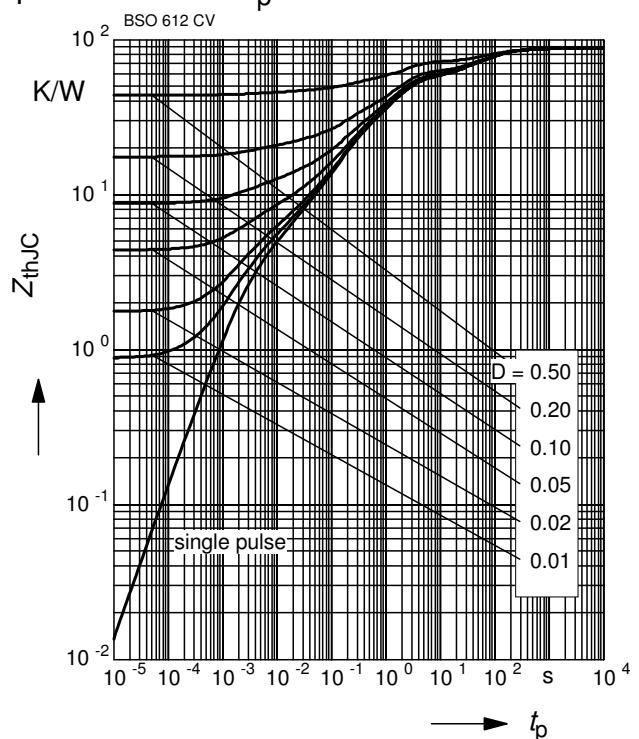
parameter : $D = t_p/T$



Transient thermal impedance (P-Ch.)

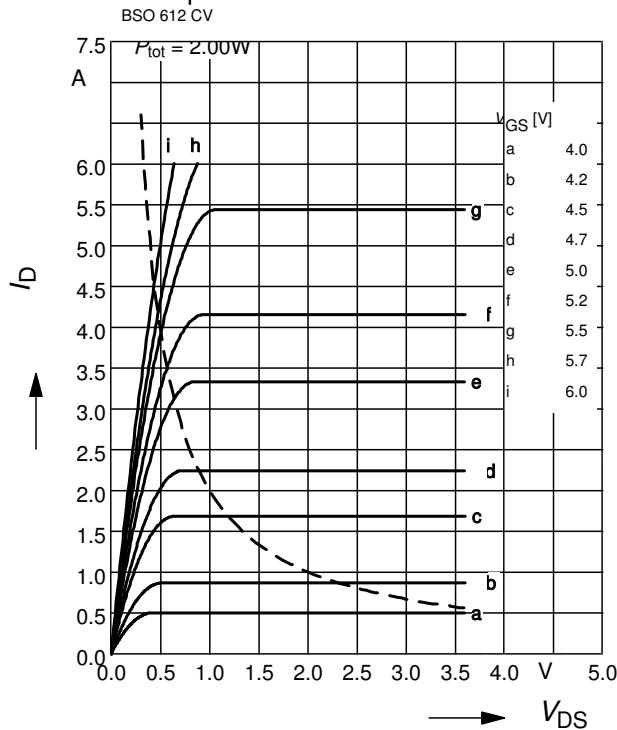
$$Z_{\text{thJC}} = f(t_p)$$

parameter : $D = t_p/T$



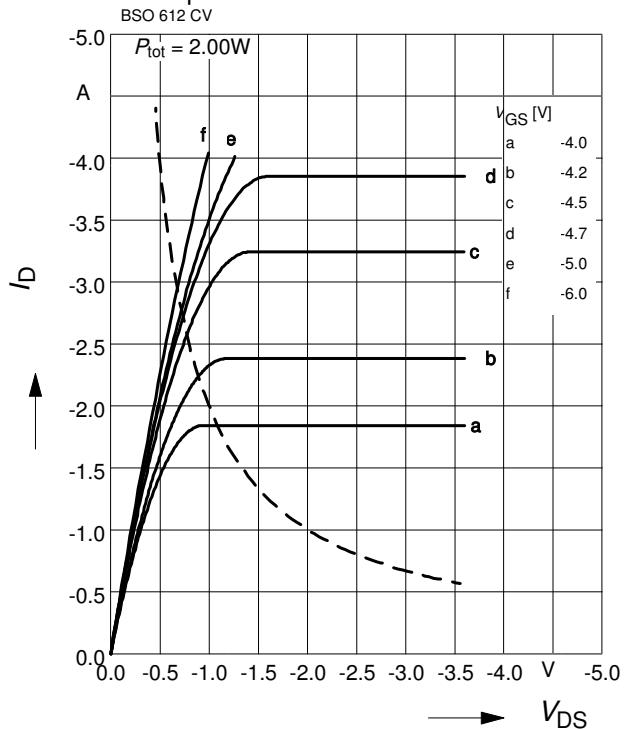
Typ. output characteristics (N-Ch.)

$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$ 

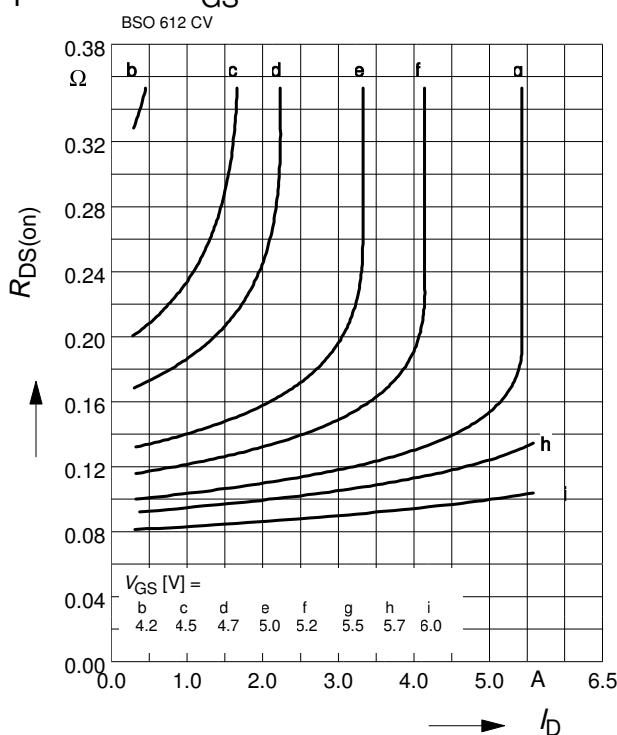
Typ. output characteristics (P-Ch.)

$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$ 

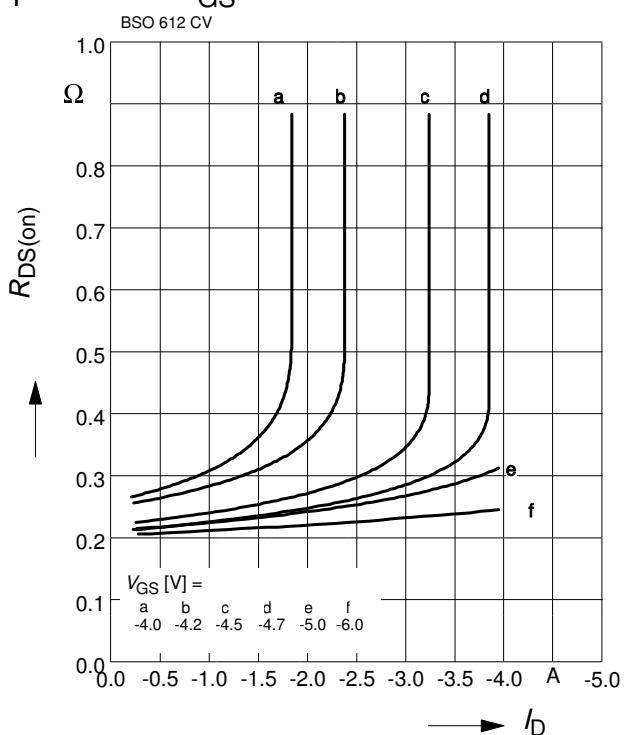
Typ. drain-source-on-resistance (N-Ch.)

$$R_{DS(\text{on})} = f(I_D)$$

parameter: V_{GS} 

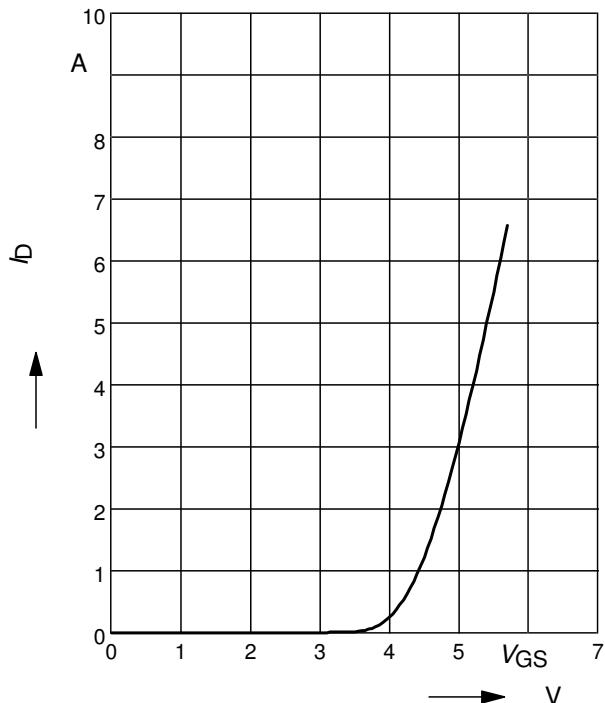
Typ. drain-source-on-resistance (P-Ch.)

$$R_{DS(\text{on})} = f(I_D)$$

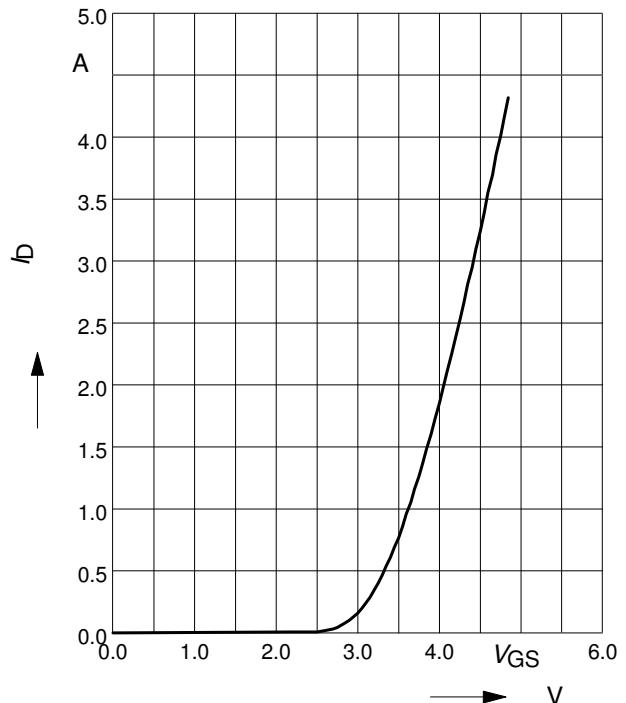
parameter: V_{GS} 

Typ. transfer characteristics (N-Ch.)parameter: $t_p = 80 \mu\text{s}$

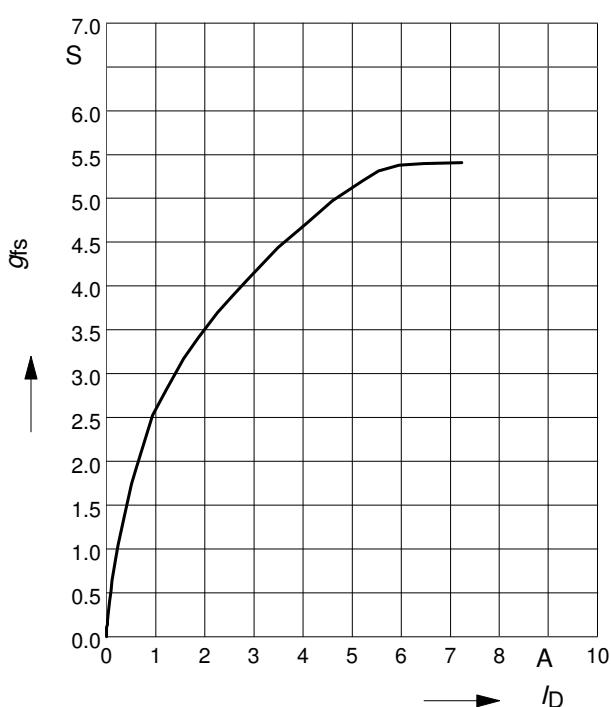
$$I_D = f(V_{GS}), V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\max}$$

**Typ. transfer characteristics (P-Ch.)**parameter: $t_p = 80 \mu\text{s}$

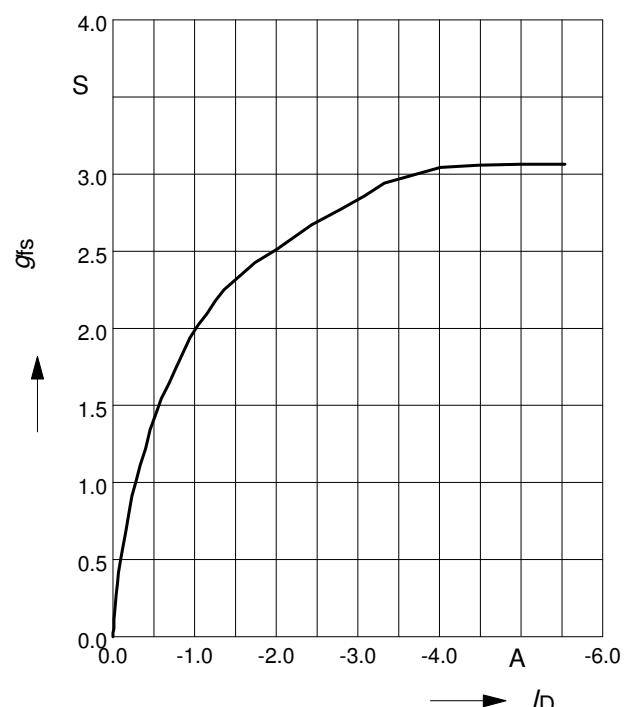
$$I_D = f(V_{GS}), V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\max}$$

**Typ. forward transconductance (N-Ch.)**

$$g_{fs} = f(I_D); T_j = 25^\circ\text{C}$$

parameter: g_{fs} **Typ. forward transconductance (P-Ch.)**

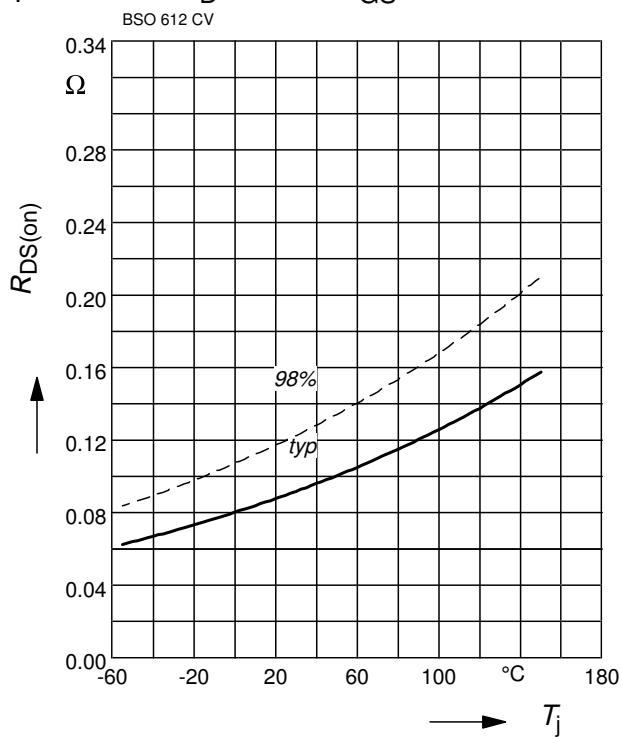
$$g_{fs} = f(I_D); T_j = 25^\circ\text{C}$$

parameter: g_{fs} 

Drain-source on-resistance (N-Ch.)

$$R_{DS(on)} = f(T_j)$$

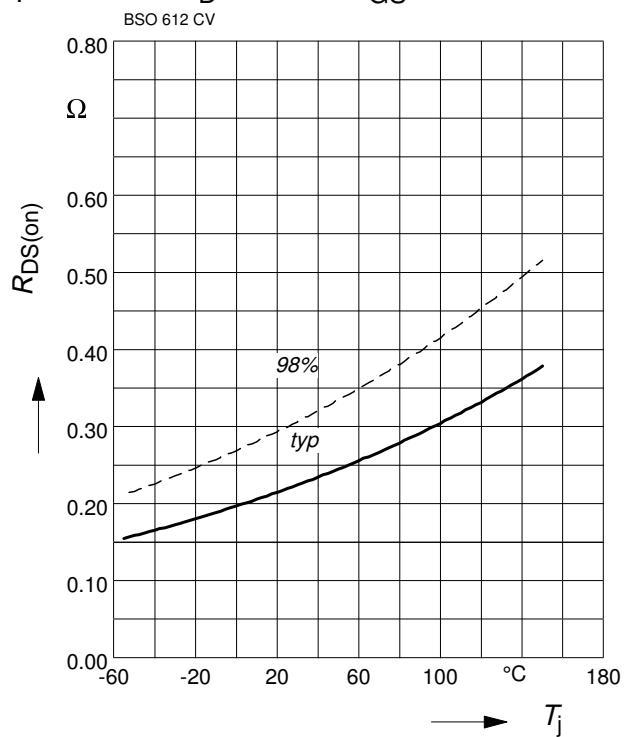
parameter : $I_D = 3 \text{ A}$, $V_{GS} = 10 \text{ V}$



Drain-source on-resistance (P-Ch.)

$$R_{DS(on)} = f(T_j)$$

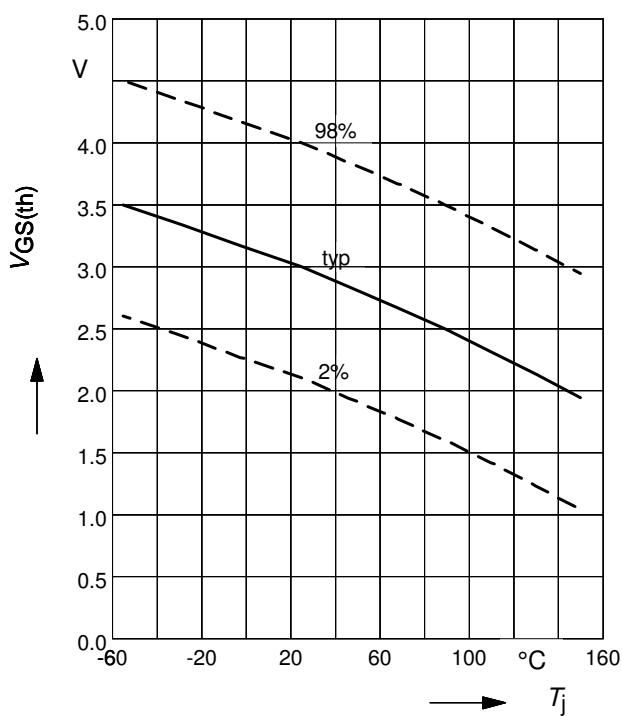
parameter : $I_D = -2 \text{ A}$, $V_{GS} = -10 \text{ V}$



Gate threshold voltage (N-Ch.)

$$V_{GS(th)} = f(T_j)$$

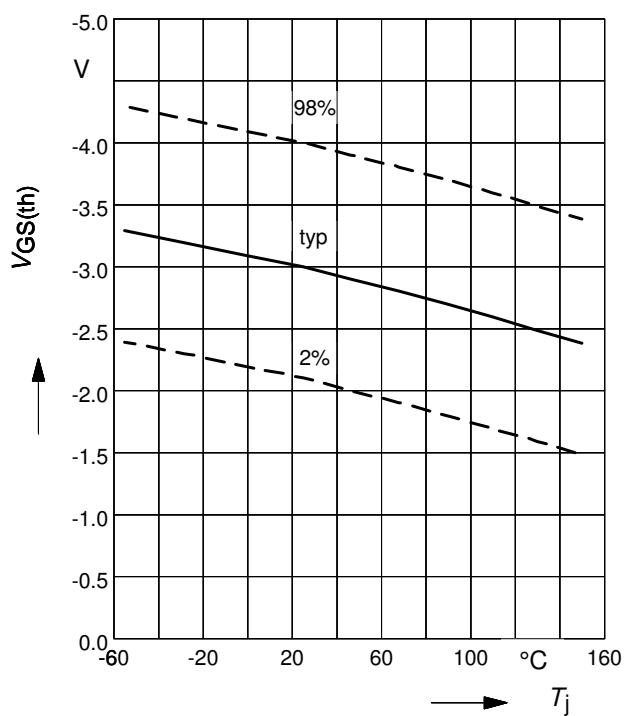
parameter: $V_{GS} = V_{DS}$, $I_D = 20 \mu\text{A}$



Gate threshold voltage (P-Ch.)

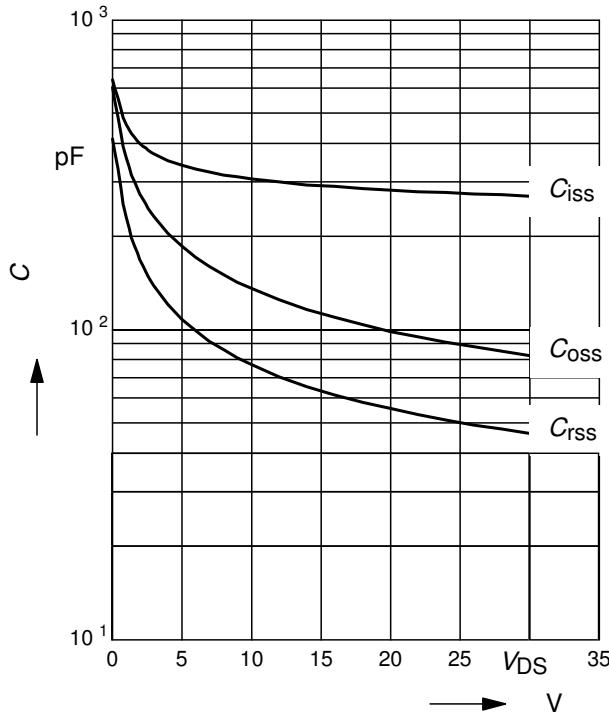
$$V_{GS(th)} = f(T_j)$$

parameter: $V_{GS} = V_{DS}$, $I_D = -450 \mu\text{A}$



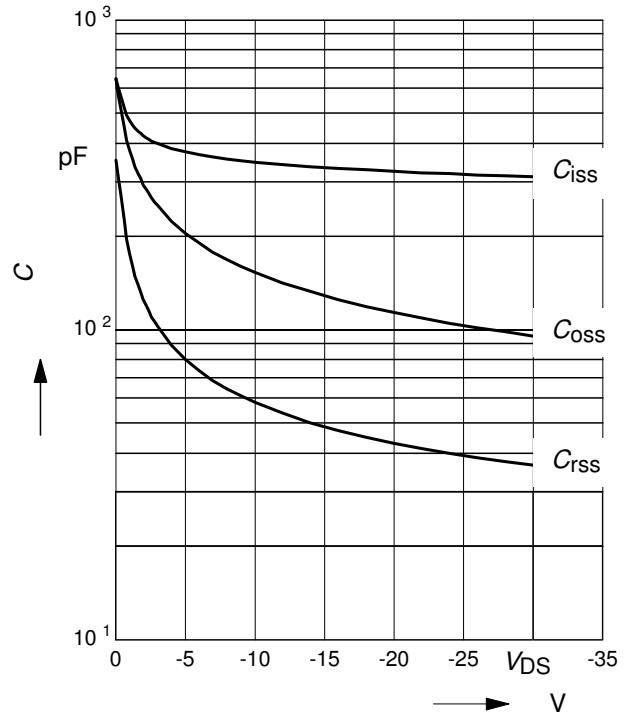
Typ. capacitances (N-Ch.)

$$C = f(V_{DS})$$

parameter: $V_{GS}=0$ V, $f=1$ MHz

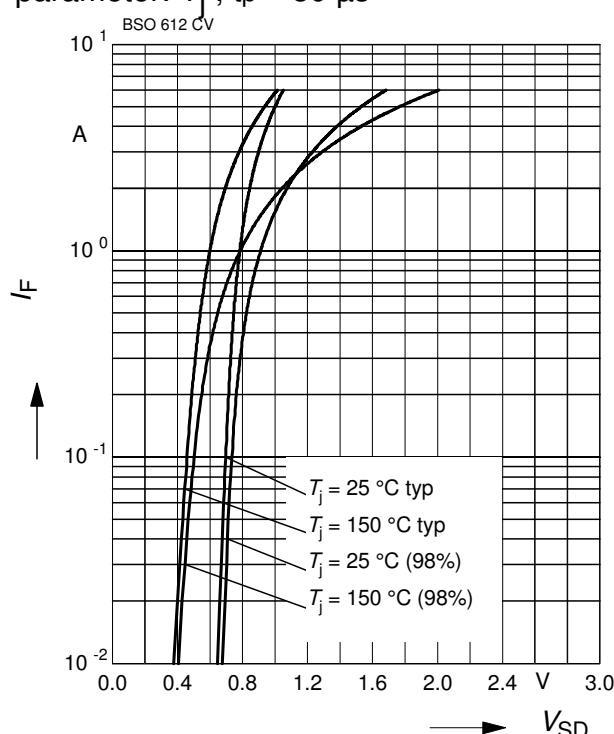
Typ. capacitances (P-Ch.)

$$C = f(V_{DS})$$

parameter: $V_{GS}=0$ V, $f=1$ MHz

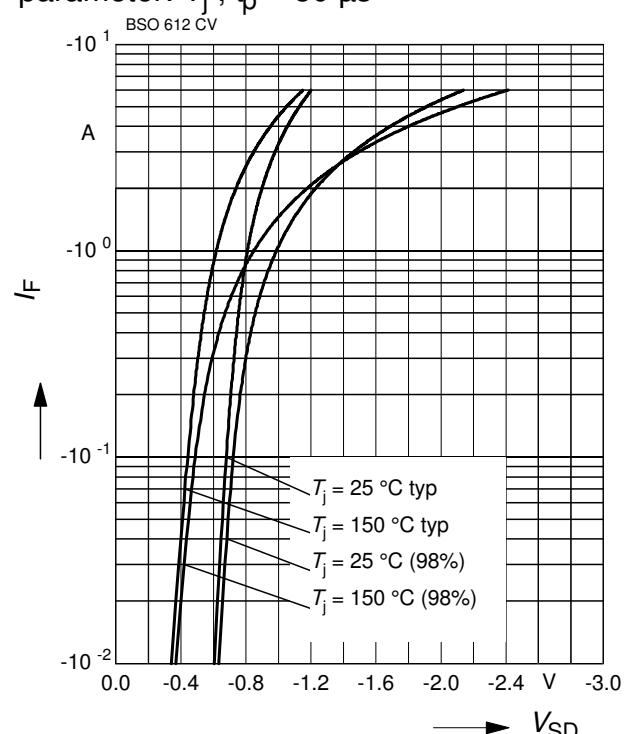
Forward characteristics of reverse diode

$$I_F = f(V_{SD}), (\text{N-Ch.})$$

parameter: T_j , $t_p = 80 \mu\text{s}$ 

Forward characteristics of reverse diode

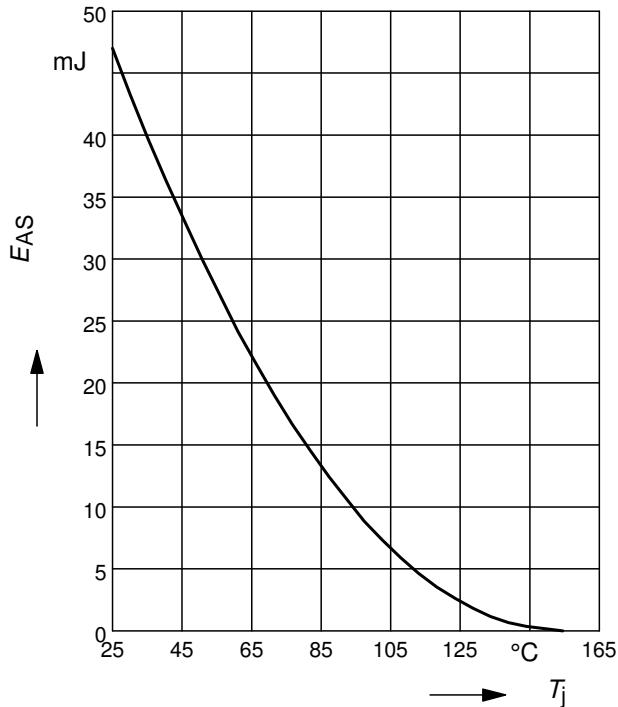
$$I_F = f(V_{SD}), (\text{P-Ch.})$$

parameter: T_j , $t_p = 80 \mu\text{s}$ 

Avalanche Energy $E_{AS} = f(T_j)$ (N-Ch.)

parameter: $I_D = 3 \text{ A}$, $V_{DD} = 25 \text{ V}$

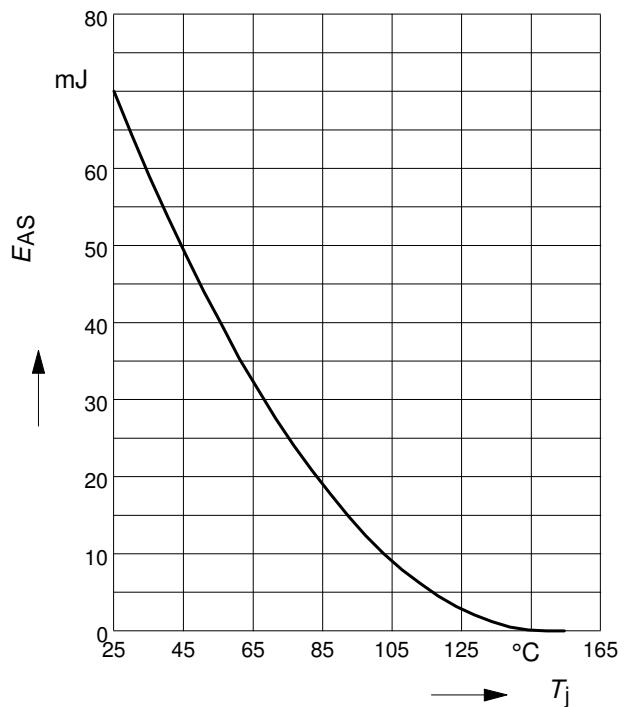
$R_{GS} = 25 \Omega$



Avalanche Energy $E_{AS} = f(T_j)$

parameter: $I_D = -2 \text{ A}$, $V_{DD} = -25 \text{ V}$

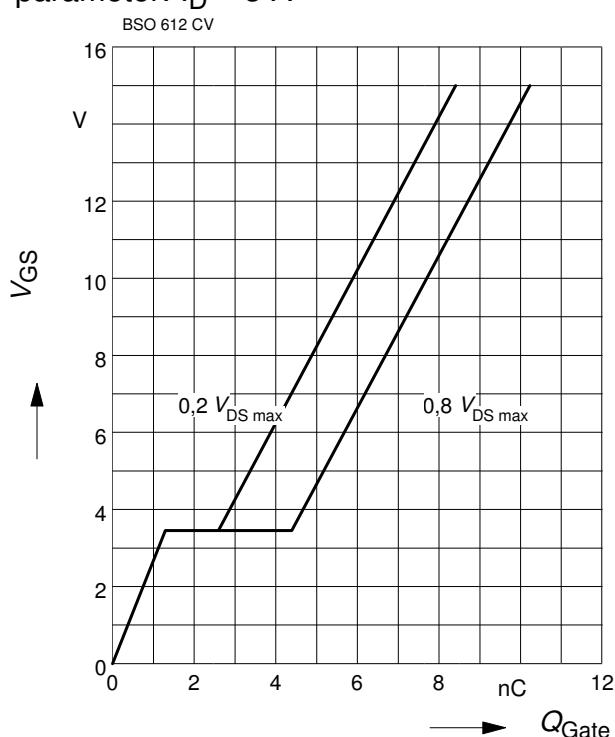
$R_{GS} = 25 \Omega$



Typ. gate charge (N-Ch.)

$V_{GS} = f(Q_{Gate})$

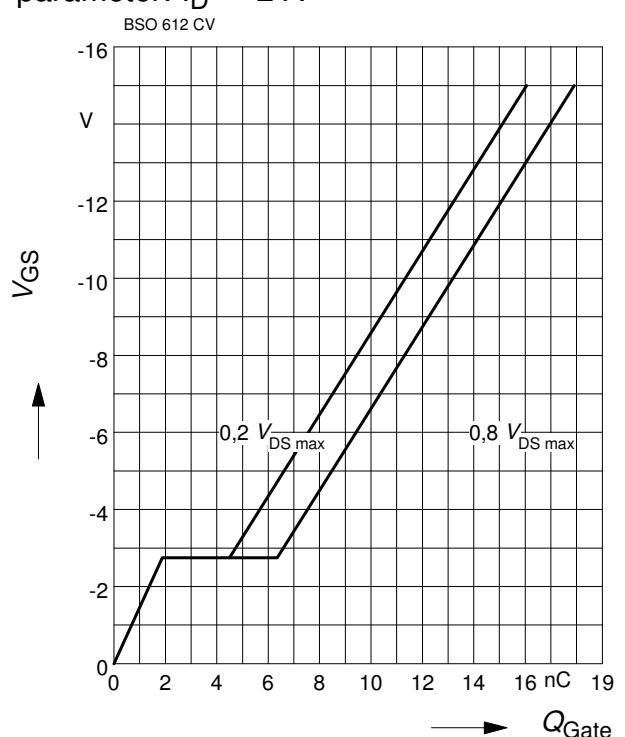
parameter: $I_D = 3 \text{ A}$



Typ. gate charge (P-Ch.)

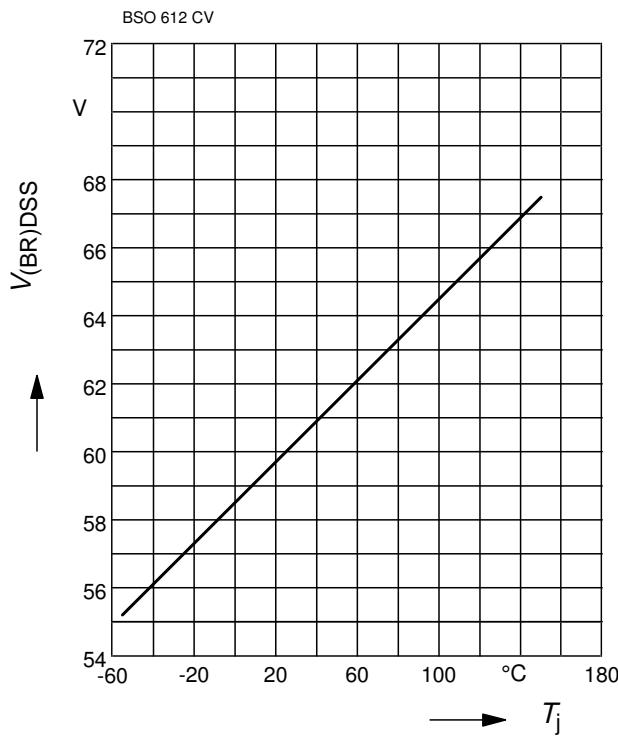
$V_{GS} = f(Q_{Gate})$

parameter: $I_D = -2 \text{ A}$

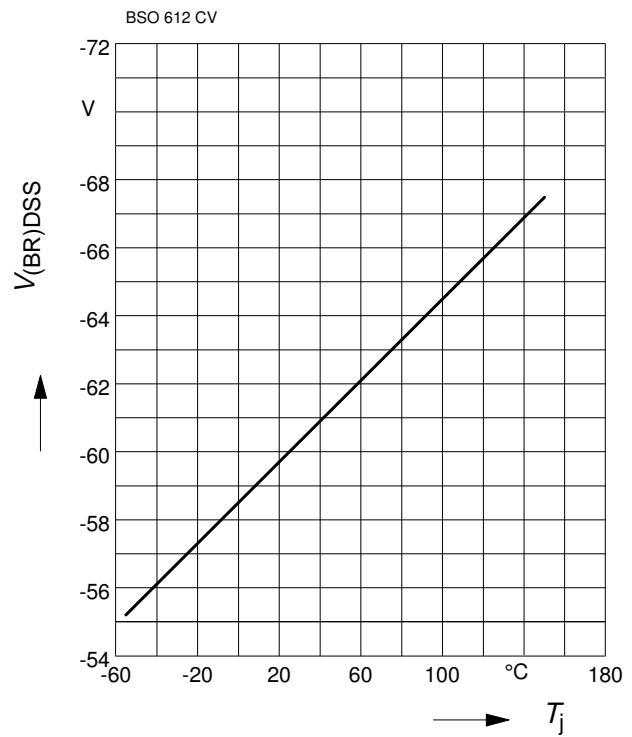


Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), \text{ (N-Ch.)}$$


Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), \text{ (P-Ch.)}$$



Revision History

BSO612CV G

Revision: 2019-08-06, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.2	2019-08-06	Update logos

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to:
erratum@infineon.com

Published by

Infineon Technologies AG

81726 München, Germany

© 2019 Infineon Technologies AG

All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics (“Beschaffenheitsgarantie”).

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.